Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/657,694	WU, JENG-SHYONG	WU, JENG-SHYONG	
Examiner	Art Unit		

2875

Anabel M. Ton

SEARCHED				
Class	Subclass	Date	Examiner	
362	84	1/18/2005	AT	
	653-656			
	644			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
,	DATE	EXMR		